

FORM HDP-1449 (Based on Form PTO-1449)

**PATENT AND TRADEMARK OFFICE
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Sheet 1 of 1

ATTORNEY DOCKET NO.

SERIAL NO.

APPLICANT

Hitoshi KUNO et al

FILING DATE

August 29, 2001

GROUP



U.S. PATENT DOCUMENTS

Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date
1.	TJW	5,741,887	4/1998	Morita et al		

FOREIGN PATENT DOCUMENTS

Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation Yes	No
1.	TJW	A8-296992	11/1996	Japan		see Application specification pages 1-2	

OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)

Ref. Desig.	Examiner's Initials	
1.		

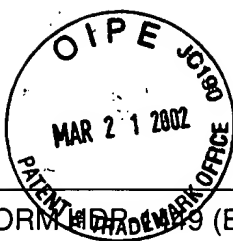
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D. Wallberg

Date Considered:

8/16/04

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Sheet 1 of 1

ATTORNEY DOCKET NO.

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4041J-000406

09/941,536

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U.S. PATENT DOCUMENTS

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FOREIGN PATENT DOCUMENTS

Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation Yes	No
1.	TJW	0 782 970 A1	7/1997	Europe		X	
2.	TJW	2001-70426	3/2001	Japan		X	

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